

<b>Notice of References Cited</b>	Application/Control No. 10/591,712		Applicant(s)/Patent Under Reexamination CHENG ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0088990	04-2005	Gibbons et al.	370/329
*	B	US-2008/0049708	02-2008	Khan et al.	370/343
*	C	US-5,673,259	09-1997	Quick, Jr., Roy F.	370/342
*	D	US-7,088,734	08-2006	Newberg et al.	370/437
*	E	US-2009/0257421	10-2009	Nakashima et al.	370/345
*	F	US-6,967,937	11-2005	Gormley, Eamonn	370/330
*	G	US-6,249,515	06-2001	Kim et al.	370/337
*	H	US-7,616,704	11-2009	Li et al.	375/299
*	I	US-2008/0227475	09-2008	Suemitsu et al.	455/513
*	J	US-2007/0064669	03-2007	Classon et al.	370/347
*	K	US-6,925,070	08-2005	Proctor, Jr., James A.	370/335
*	L	US-5,740,167	04-1998	Taketsugu et al.	370/337
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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